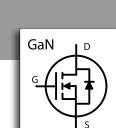
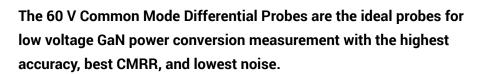


60 V Common Mode Differential Probes DL05-HCM (500 MHz) DL10-HCM (1 GHz)





Ideal Probes for 48 V GaN Power Conversion

60 V of common mode and 80 V differential input range with 1 GHz of bandwidth, make these probes ideal for low voltage GaN power conversion measurements. The 60 V of common mode is well suited for handling any float of the battery and bulk/absorption voltage during charging, while the 80 V differential input range provide margin for any overshoot.

Highest Accuracy

The DL-HCM probes are calibrated for high-precision measurements to within 0.5% at DC and 0.1 dB flatness from DC to 100 MHz. This provides for high accuracy of top and base voltage levels of pulse-width modulated signals. The Precision Gain Calibration capability permits further measurement precision by improving the gain accuracy and removing small offset drifts from the measurement configuration.

Lowest Noise and Highest Rejection

The Common Mode Rejection Ratio (CMRR) is exceptional to very high frequencies. This provides for the best measurement performance when measuring very fast slew rate (high dV/dt) PWM signals typical of GaN devices and systems. Exceptional CMRR combined with low probe noise and high offset capability makes the probes capable of measuring very small control signals floating on high common mode voltages.

Wide Variety of Tips

The DL-HCM probes provide the perfect combination of high performance and flexibility for connecting to any device under test. An optional accessory kit and high temperature solder-in tip are available for further connectivity options.

Key Applications

- 48 V motors and drives
- High-power DC-DC converters
- GaN-based PDNs
- AC-DC switch-mode power supplies
- Wireless charging systems
- Gate-drive measurements

Key Features

Ideal probe for 48 V Power Conversion

- 500 MHz and 1 GHz bandwidth
- 80 V dynamic range
- 60 V common mode

Highest accuracy

- 0.5% gain accuracy
- Precision gain calibration
- Best LF flatness (0.1 dB)

Lowest noise and highest rejection

Wide variety of tips

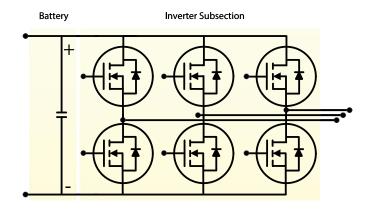
- High performance solder-in
- Browser
- Single pins and header
- Mini and micro grabbers
- Socketed connections
- High temp solder-in
- Y-banana adaptor

ProBus active probe interface

BEST PROBE FOR 48 V POWER CONVERSION TESTING

48 V Battery-powered Motor and Drive Systems

Higher battery voltages require differential probes with suitable common mode ratings and peak voltage differential swings that can only be supplied with DL-HCM probes. 1 GHz permits accurate measurements on GaN power conversion systems.



DC Bus or Battery Voltage	DC Battery Charging Voltage	Drive/Inverter Pulse-Width Modulated (PWM) Output			
V _{dc}	V _{dc}	V _{pk} Line-Line or Line-Ref (Rated)		V _{pk} Line-Line or Line-Ref (with Overshoot)*	
do	do	Operating	Charging	Operating	Charging
12	13.8	12	13.8	14.4	16.6
18	20.7	18	20.7	21.6	24.8
36	41.4	36	41.4	43.2	49.7
48	55.2	48	55.2	57.6	66.2
56	64.4	56	64.4	67.2	77.3

*assumes 20% signal overshoot

- All-purpose probe for DC (battery),
 Device, Gate-drive and Inverter Output measurements
- 60 V common-mode exceeds requirements during battery-charging
- 60 V offset range for DC ripple measurements
- 80 V (DC + peak AC) differential swing for overshoot events
- Low attenuation with multiple ranges for best noise performance

High-power DC-DC Converters

Higher-power DC-DC converters used in server and vehicle applications operate through a wide dynamic range. DL-HCM probes provide the common mode and peak voltage needed for up to 60 V inputs, and the dynamic range to measure much smaller output voltages.

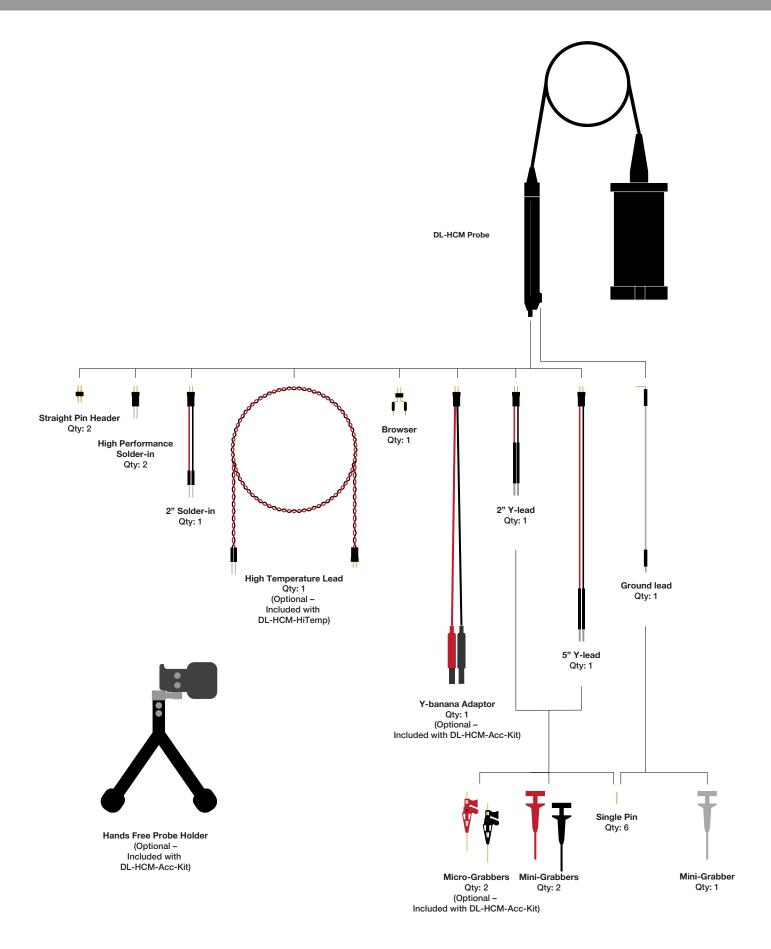
- All-purpose probe for DC (battery),
 Device, Gate-drive and Inverter Output measurements
- High-sensitivity (200 mV/div)
- 0.5% DC gain accuracy
- 60 V common mode and offset ranges

GaN Buck, Boost and Half-Bridge Systems

Faster switching speeds made possible by GaN devices are making a variety of low-power power conversion systems lighter, smaller, and more efficient. DL-HCM probes provide the bandwidth and performance necessary for testing various low-power GaN systems.

- Power distribution networks (PDNs)
- AC-DC switch-mode power supplies (SMPS)
- DC-DC converters
- Wireless charging systems

WIDE VARIETY OF TIPS



SPECIFICATIONS AND ORDERING INFORMATION

	DL05-HCM	DL10-HCM			
Bandwidth*	500 MHz (guaranteed, without leads)	1 GHz (guaranteed, without leads)			
	500 MHz (High performance solder-in and browser)	1 GHz (High performance solder-in and browser)			
	500 MHz (2" Y-lead/solder-in)	800 MHz (2" Y-lead)			
	500 MHz (5" Y-lead)	700 MHz (solder-in)			
	30 MHz (Hi-Temp lead)	500 MHz (5" Y-lead)			
		30 MHz (Hi-Temp lead)			
Rise Time (10-90%)*	700 ps	350 ps			
Differential Voltage Range	80 V (DC + peak AC) from 200 mV/div to 20 V/div				
Common Mode Voltage Range	±60 V (DC + peak AC)				
Maximum Input Voltage to Eartl	n 80 V (DC + peak AC), max 60 V DC (either input to groun				
Maximum Safe Input Voltage	For Hand-held use: 28.28 Vrms or 60 V DC (referenced to ground) per IEC/EN 61010-031:2015				
Sensitivity	200 mV/div to 1 V/div (7.8x)				
	1.02 V/div to 2.5 V/div (17.5x)				
	2.55 V/div to 20 V/div (70x)				
DC Gain Accuracy	±0.5% (guaranteed)				
DC Gain Drift	≤ 0.075%/°C, can be calibrated out with precision gain of	eal			
Frequency Response Flatness	DC to 100MHz: 0.1 dB				
Offset Range	±60V				
Attenuation	7.8x / 17.5x / 70x				
Input Impedance	200 kΩ 0.6 pF (between inputs), 100 kΩ 1 pF (either input to ground)				
Input/Output Coupling	DC				
Output Termination	50 Ω				
Interface	ProBus				
Cable Length	1.42 m from probe sockets to oscilloscope connection				
Noise and Rejection					
CMRR	DC - 10 kHz: 80 dB	DC - 10 kHz: 80 dB			
	100 kHz: 70 dB	100 kHz: 70 dB			
	1 MHz: 55 dB	1 MHz: 55 dB			
	100 MHz: 50 dB 500 MHz: 35 dB	100 MHz: 50 dB 1 GHz: 30 dB			
Noise (Probe)	200 mV/div to 1 V/div: 3.25mV _{rms}	200 mV/div to 1 V/div: 4.3mV _{rms}			
Noise (Flobe)	1.02 V/div to 2.5 V/div: 4.5mV _{rms}	1.02 V/div to 2.5 V/div: 6mV _{rms}			
	2.55 V/div to 20 V/div: 14.5mV _{rms}	2.55 V/div to 20 V/div: 011V _{ms}			
	2.55 V/UIV to 20 V/UIV. 14.5ITIV _{rms}	2.55 V/div to 20 V/div. 20111V _{rms}			
Environmental					
Temperature	0°C to 50°C (Operating), -40°C to 70°C (Non-Operating)				
Humidity (Operating)	5% to 90% RH (Non-Condensing) up to 30°C, decreasing				
Humidity (Non-Operating)	5% to 95% RH (Non-Condensing), 75% RH above 40°C, 45% RH above 50°C				
Altitude (Operating)	Up to 3000 m (9842 ft)				
Certifications					
CE Declaration of Conformity	Conforms to EN61010-031:2015, EN61326-1:2013, and E	N50581:2012			
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^{*} All Bandwidth and Rise Time measurements are made without leads and an oscilloscope bandwidth greater than the probe bandwidth.

Ordering Information

Product Description	Product Code	Standard leads and tips	
500 MHz 60V Common Mode Differential Probe. Includes standard set of leads and tips.	2" solder-in tip	•	
1 GHz 60V Common Mode Differential Probe. Includes standard set of leads and tips.	DL10-HCM	Browser Y-lead socket (2" and 5")	
DL-HCM series high-temperature solder-in tip, 30 MHz bandwidth, 1 meter length.	DL-HCM-HiTemp	Mini grabbers (Qty. 3) Ground lead Giarda min (Qty. 6)	
DL-HCM series accessories kit with probe holder, micro IC grabbers (Qty 2.), and Y-banana adaptor.	DL-HCM-Acc-Kit	Single pin (Qty. 6) Straight pin header (Qty. 2)	

Customer Service

Teledyne LeCroy oscilloscopes and probes are designed, built, and tested to ensure high reliability. In the unlikely event you experience difficulties, our digital oscilloscopes are fully warranted for three years and our probes are warranted for one year. This warranty includes:

• No charge for return shipping • Long-term 7-year support • Upgrade to latest software at no charge



1-800-5-LeCroy teledynelecroy.com

Local sales offices are located throughout the world. Visit our website to find the most convenient location.